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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/501,597	YU ET AL.	
Examiner	Art Unit	
Tez K Chiu	2822	

SEARCHED				
Class	Subclass	Date	Examiner	
257	59,72	4/1/2007	тс	
257	764-765	4/1/2007	TC .	
257	770-771	4/1/2007	TC	

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (text search see attach)	4/1/2007	тс		
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